

**Search Notes**

Application/Control No.

10/799,596

Examiner

Emily Y. Chan

Applicant(s)/Patent under  
Reexamination

YANO ET AL.

Art Unit

2829

**SEARCHED**

| Class  | Subclass | Date       | Examiner |
|--------|----------|------------|----------|
| 324    | 770      | 10/24/2005 | EC       |
| SEARCH | UPDATED  | 10/24/2005 | EC       |
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**INTERFERENCE SEARCHED**

| Class   | Subclass | Date       | Examiner |
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| US PG PUB searched<br>(see History print out) |          | 10/24/2005 | EC       |

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|   | DATE       | EXMR |
|---|------------|------|
| Inventorship and Plus searched  | 8/16/2005  | EC   |
| 324/767,770 and G09G/3/32 IPC (text<br>searched -only see search history<br>printout) | 8/16/2005  | EC   |
| 324/767,765,158.1 (text search only-<br>see search history printout)                  | 10/24/2005 | EC   |
| Consulted with primary examiner Mr.<br>VINH P. NGUYEN.                                | 10/24/2005 | EC   |
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